

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 293259US0PCT		SERIAL NO. 10/586,967	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Nicolas NADAUD, et al.			
				FILING DATE September 25, 2006		GROUP 1714	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO	JP 2001-331933	11/30/01	Japan w/English Abstract			
	AP	JP 04-250400	11/7/00	Japan w/English Abstract			
	AQ	JP 2-11020	08/22/90	Japan w/English Abstract			
	AR	JP 2-230435	09/24/00	Japan w/English Abstract			
	AS	JP 2-529072	09/03/02	Japan			
	AT	JP 7-165442	05/27/05	Japan w/English Abstract			
	AU	JP 8-200740	09/17/06	Japan w/English Abstract			
	AV	WO 00/57440	09/12/00	WIPO w/English Abstract			
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW	Office Action dated February 22, 2011 as received in the corresponding Japanese Patent Application No. 2006-550254					
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner				/Ryan Coleman/		Date Considered 08/31/2011	
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

293259US0PCT

SERIAL NO.

10/586,967

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Nicolas NADAUD, et al.

FILING DATE

September 25, 2006

GROUP

1714

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
	AO	JP 4 320805	08/10/03	Japan w/English Abstract		
	AP	JP 7 473873	07/11/05	Japan w/English Abstract		
	AQ	2003-500327	03/11/03	Japan w/English Abstract		
	AR	WO 2004/005210	01/13/04	WFO w/English Abstract		
	AS	JP10 353005	00/25/08	Japan w/English Abstract		
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	<input type="checkbox"/> Additional References sheet(s) attached

Examiner /Ryan Coleman/

Date Considered 08/31/2011

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.